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FDN340P

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FAIRCHILD SEMICONDUCTOR

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# FDN340P

## Single P-Channel, Logic Level, PowerTrench® MOSFET

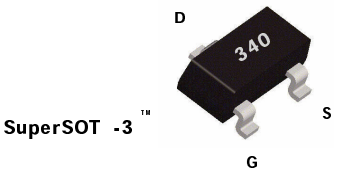
### General Description

This P-Channel Logic Level MOSFET is produced using Fairchild Semiconductor advanced Power Trench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

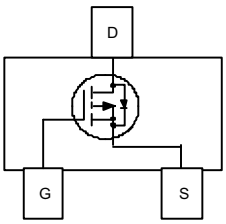
These devices are well suited for portable electronics applications: load switching and power management, battery charging circuits, and DC/DC conversion.

### Features

- –2A, 20 V $R_{DS(ON)}$ = 70 mΩ @ $V_{GS}$ = –4.5 V
  $R_{DS(ON)}$ = 110 mΩ @ $V_{GS}$ = –2.5 V
- Low gate charge (7.2 nC typical).
- High performance trench technology for extremely low $R_{DS(ON)}$ .
- High power version of industry Standard SOT-23 package. Identical pin-out to SOT-23 with 30% higher power handling capability.



SuperSOT -3™




## Absolute Maximum Ratings $T_A$=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|---|---|---|---|---|
| $V_{DSS}$ | Drain-Source Voltage | | –20 | V |
| $V_{GSS}$ | Gate-Source Voltage | | ±8 | V |
| $I_D$ | Drain Current – Continuous | (Note 1a) | –2 | A |
| | – Pulsed | | –10 | |
| $P_D$ | Power Dissipation for Single Operation | (Note 1a) | 0.5 | W |
| | | (Note 1b) | 0.46 | |
| $T_J$, $T_{STG}$ | Operating and Storage Junction Temperature Range | | –55 to +150 | °C |

## Thermal Characteristics

| | | | | |
|---|---|---|---|---|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 250 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 75 | °C/W |

## Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|---|---|---|---|---|
| 340 | FDN340P | 7” | 8mm | 3000 units |

## Electrical Characteristics

$T_A$ = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain–Source Breakdown Voltage | $V_{GS}$ = 0 V, $I_D$ = –250 µA | –20 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = –250 µA,Referenced to 25°C | | –12 | | mV/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = –16 V, $V_{GS}$ = 0 V | | | –1 | µA |
| | | $V_{DS}$ = –16 V, $V_{GS}$ = 0 V,$T_J$=55°C | | | –10 | |
| $I_{GSSF}$ | Gate–Body Leakage, Forward | $V_{GS}$ = 8 V, $V_{DS}$ = 0 V | | | 100 | nA |
| $I_{GSSR}$ | Gate–Body Leakage, Reverse | $V_{GS}$ = –8 V, $V_{DS}$ = 0 V | | | –100 | nA |
| **On Characteristics** (Note 2) | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_D$ = –250 µA | –0.4 | –0.8 | –1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D$ = –250 µA,Referenced to 25°C | | 3 | | mV/°C |
| $R_{DS(on)}$ | Static Drain–Source On–Resistance | $V_{GS}$ = –4.5 V, $I_D$ = –2 A | | 60 | 70 | mΩ |
| | | $V_{GS}$ = –4.5 V, $I_D$ = –2 A,$T_J$=125°C | | 77 | 120 | |
| | | $V_{GS}$= –2.5 V, $I_D$ = –1.7A, | | 82 | 110 | |
| $I_{D(on)}$ | On–State Drain Current | $V_{GS}$ = –4.5 V, $V_{DS}$ = –5 V | –5 | | | A |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = –4.5 V, $I_D$ = –2 A | | 9 | | S |
| **Dynamic Characteristics** | | | | | | |
| 600 | Input Capacitance | $V_{DS}$ = –10 V, $V_{GS}$ = 0 V, f = 1.0 MHz | | 779 | | pF |
| 175 | Output Capacitance | | | 121 | | pF |
| 80 | Reverse Transfer Capacitance | | | 56 | | pF |
| **Switching Characteristics** (Note 2) | | | | | | |
| $t_{d(on)}$ | Turn–On Delay Time | $V_{DD}$ = –10 V, $I_D$ = –1 A, $V_{GS}$ = –4.5 V, $R_{GEN}$ = 6 Ω | | 10 | 20 | ns |
| $t_r$ | Turn–On Rise Time | | | 9 | 10 | ns |
| $t_{d(off)}$ | Turn–Off Delay Time | | | 27 | 43 | ns |
| $t_f$ | Turn–Off Fall Time | | | 11 | 20 | ns |
| $Q_g$ | Total Gate Charge | $V_{DS}$ = –10V, $I_D$ = –3.5 A, $V_{GS}$ = –4.5 V | | 7.2 | 10 | nC |
| $Q_{gs}$ | Gate–Source Charge | | | 1.7 | | nC |
| $Q_{gd}$ | Gate–Drain Charge | | | 1.5 | | nC |
| **Drain–Source Diode Characteristics and Maximum Ratings** | | | | | | |
| $I_S$ | Maximum Continuous Drain–Source Diode Forward Current | | | | –0.42 | A |
| $V_{SD}$ | Drain–Source Diode Forward Voltage | $V_{GS}$ = 0 V, $I_S$ = –0.42 A (Note 2) | | –0.7 | –1.2 | V |

**Notes:**

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a. 250°C/W when mounted on a 0.02in² pad of 2 oz copper

b. 270°C/W when mounted on a .001 in² pad of 2 oz copper

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

## Typical Characteristics

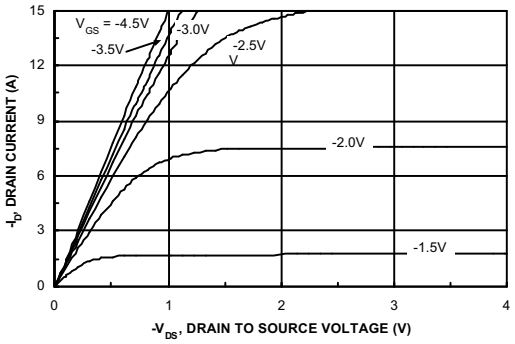



**Figure 1. On-Region Characteristics.**

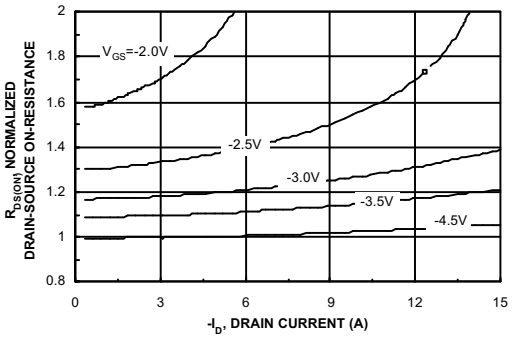



**Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.**

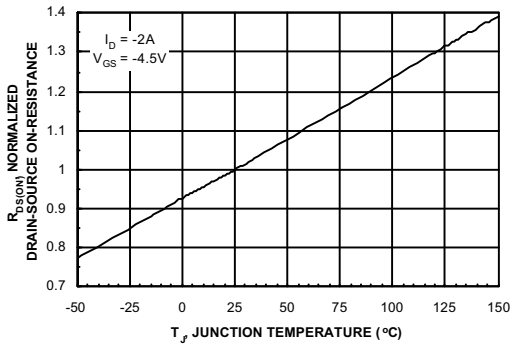



**Figure 3. On-Resistance Variation with Temperature.**

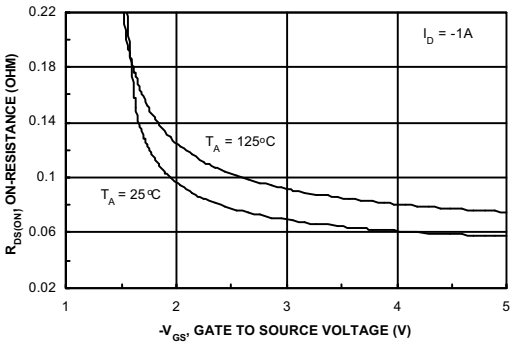



**Figure 4. On-Resistance Variation with Gate-to-Source Voltage.**

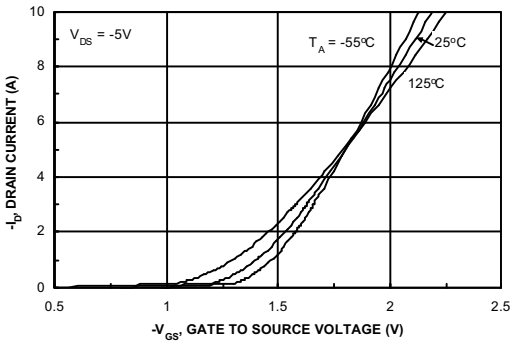



**Figure 5. Transfer Characteristics.**

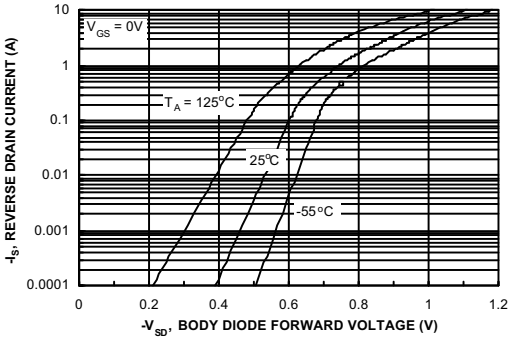



**Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.**

## Typical Characteristics

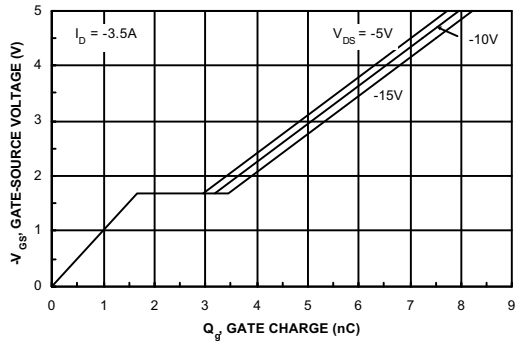



**Figure 7. Gate Charge Characteristics.**

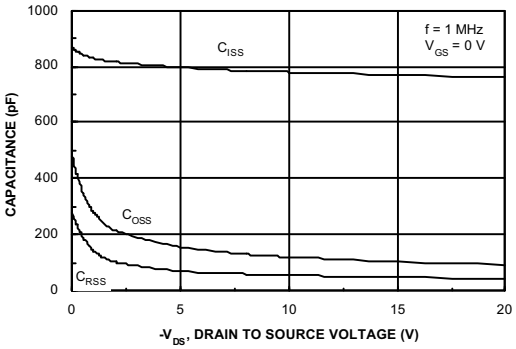



**Figure 8. Capacitance Characteristics.**

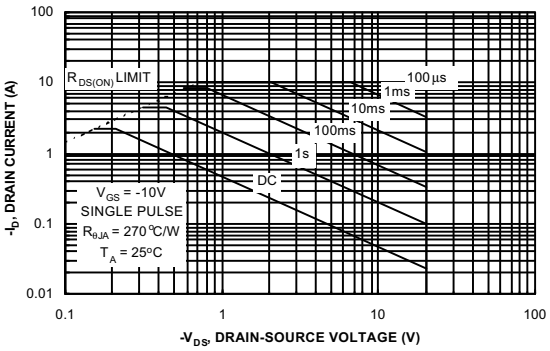



**Figure 9. Maximum Safe Operating Area.**

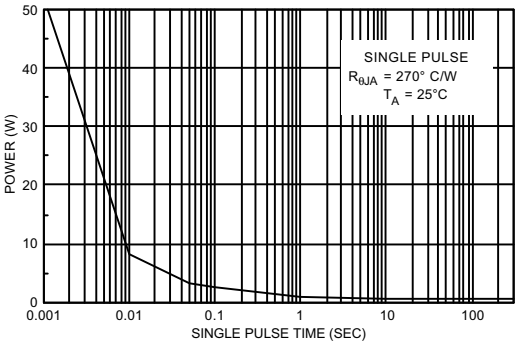



**Figure 10. Single Pulse Maximum Power Dissipation.**

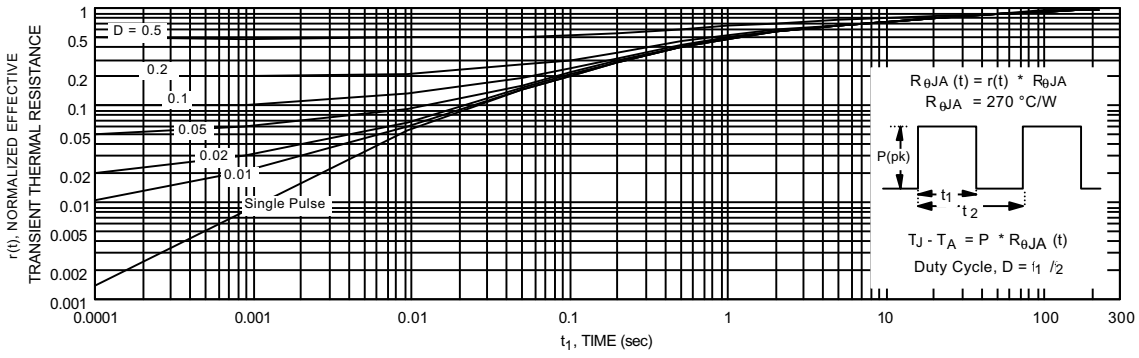



**Figure 11. Transient Thermal Response Curve.**

**Thermal characterization performed using the conditions described in Note 1b.**
**Transient thermal response will change depending on the circuit board design.**

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